

<b>Notice of References Cited</b>	Application/Control No.	Applicant(s)/Patent Under Reexamination	
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	Examiner	Art Unit	Page 1 of 1
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	D	US-			
	E	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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	V	Sijpesteijn, Antonie van Leeuwenhoek 1970, Vol.36, p.335-348.
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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